Search Notes		

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/713,879	LIU ET AL.	
	Examiner	Art Unit	-
	Frin D. Chiem	2883	

	SEAR	CHED	
Class	Subclass	Date	Examiner
			-·

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAF		)
	DATE	EXMR
Consulted Brian Healy	8/18/2006	EDC